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Features

- Frequency Range 2.4 GHz to 2.5 GHz
- Supply Voltage 2.7V to 3.6V
- 32 dB Power Gain
- 23 dBm Linear Output Power for IEEE 802.11b Mode Operation
- EVM < 2.0% at 19 dBm Output Power for IEEE 802.11g Mode Operation
- On-chip Power Detector with 20 dB Dynamic Range
- Power-down Mode and Biasing Control
- Input and Interstage Matching Fully On-chip
- Low Profile Lead-free Plastic Package QFN16 (3 mm × 3 mm × 0.9 mm)

Applications

- IEEE 802.11b DSSS WLAN
- IEEE 802.11g OFDM WLAN
- Bluetooth 2.0 Enhanced Data Rate
- PC Cards, PCMCIA, Access Points
- 2.4 GHz ISM Band Application

1. Description

This power amplifier (PA) is designed for high-performance 802.11b and 802.11g multi-mode applications such as Mini PCI and PCMCIA for portable devices and access points. The low profile plastic package with internal input matching to 50Ω and on-chip interstage matching minimizes the PCB board-space and allows simplified integration with very few passive components. The on-chip power detector provides a voltage linear to the output power, while the standby/bias control logic provides power-saving and shutdown options. The PA is realized as a three stage PA with internal interstage matching and an open-collector output structure.

The power amplifier is designed using Atmel®'s Silicon-Germanium (SiGe₂) process and provides excellent linearity and noise performance, high gain, and good power-added efficiency.

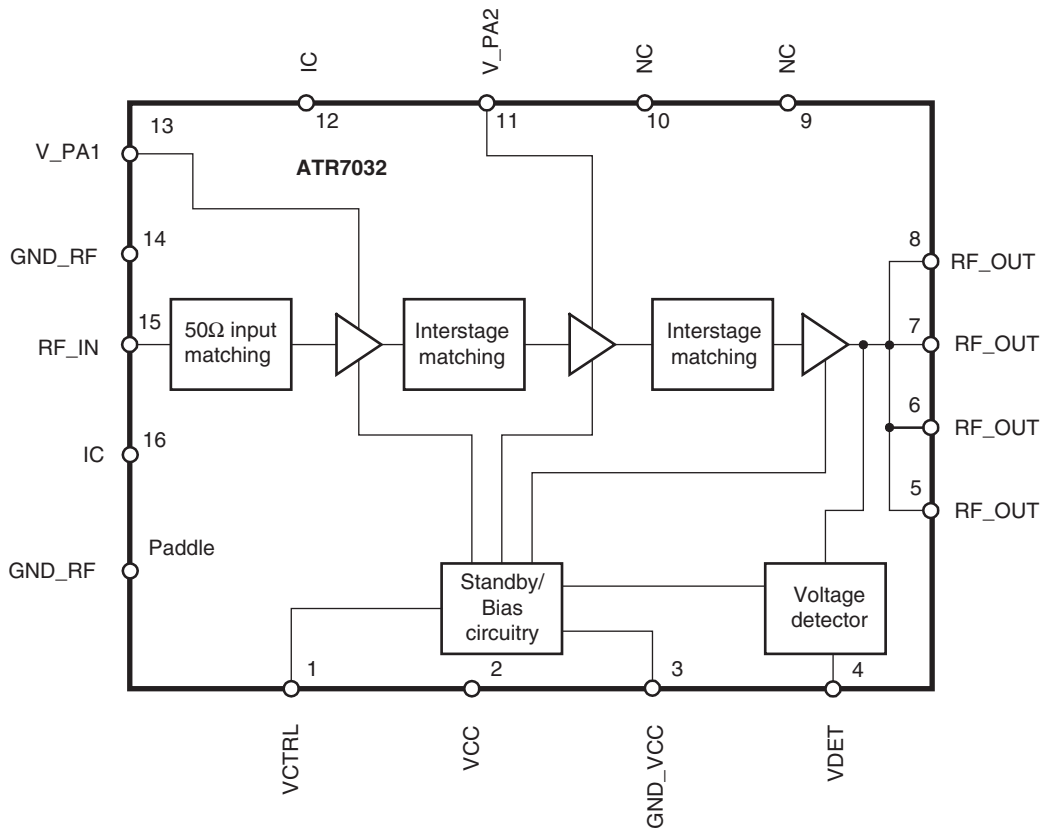


High Gain Power Amplifier for 802.11b/g WLAN Systems

ATR7032



Figure 1-1. Block Diagram



2. Pin Configuration

Figure 2-1. Pinning QFN16

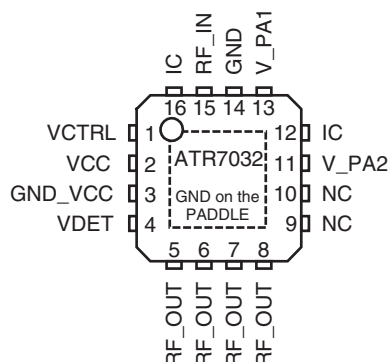


Table 2-1. Pin Description

| Pin | Symbol | Function |
|--------|---------|--|
| 1 | VCTRL | Power-up/biasing control voltage |
| 2 | VCC | Supply voltage |
| 3 | GND_VCC | Ground |
| 4 | VDET | Power detector voltage |
| 5 | RF_OUT | RF output |
| 6 | RF_OUT | RF output |
| 7 | RF_OUT | RF output |
| 8 | RF_OUT | RF output |
| 9 | NC | Not connected |
| 10 | NC | Not connected |
| 11 | V_PA2 | Supply voltage PA stage 2 |
| 12 | IC | Internally connected, on-chip matching; must not be externally connected |
| 13 | V_PA1 | Supply voltage PA stage 1 |
| 14 | GND | Ground |
| 15 | RF_IN | RF input |
| 16 | IC | Internally connected, on-chip matching; must not be externally connected |
| PADDLE | GND | Ground on the PADDLE |

3. Absolute Maximum Ratings

Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

| Parameters | Test Conditions | Symbol | Value | Unit |
|---|-------------------|-------------|-------------|------|
| Supply voltage | Without RF | V_{CC} | 5 | V |
| Supply current | | I_{CC} | 600 | mA |
| Junction temperature | | T_j | 150 | °C |
| Storage temperature | | T_{Stg} | -40 to +125 | °C |
| Input RF power | | P_{IN} | 12 | dBm |
| Control voltage power up/down and biasing | | V_{VCTRL} | 0 to +3.0 | V |
| ESD protection, all pins | EIA/JESD22-A114-B | V_{ESD} | 500 | V |

Note: 1. The part may not survive all maximums applied simultaneously.

4. Operating Range

| Parameters | Symbol | Value | Unit |
|---------------------------|-----------|--------------|------|
| Supply voltage range | V_{CC} | 2.7 to 3.6 | V |
| Ambient temperature range | T_{amb} | -40 to +85 | °C |
| Frequency range | f | 2400 to 2500 | MHz |

5. Electrical Characteristics

Test Conditions measured on Atmel's evaluation board (unless otherwise stated): $V_{CC} = 3.3V$, Frequency = 2.45 GHz, $T_{amb} = 25^\circ C$

| No. | Parameters | Test Conditions | Pin | Symbol | Min. | Typ. | Max. | Unit | Type* |
|-----|-----------------------|-------------------|-----|--------------|------|------|------|------|-------|
| 1.0 | Control voltage range | PA operating mode | | V_{VCTRL} | 1 | | 2 | V | A |
| 1.1 | | Power down mode | | V_{VCTRL} | | | 0.2 | | A |
| 1.2 | Current consumption | Quiescent | | I_{CC_Q} | | 90 | | mA | A |
| 1.3 | | Power down mode | | I_{CC_PD} | | | 10 | µA | A |
| 1.4 | | PA operating mode | | I_{VCTRL} | | | 100 | µA | A |

*) Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

6. Electrical Characteristics – Unmodulated Carrier

Test Conditions measured on Atmel's evaluation board (unless otherwise stated): $V_{CC} = 3.3V$, Frequency = 2.45 GHz, $T_{amb} = 25^{\circ}C$

| No. | Parameters | Test Conditions | Pin | Symbol | Min. | Typ. | Max. | Unit | Type* |
|-----|------------------------|--|-----|--|------|------------|------|------------|--------|
| 2.0 | Saturated output power | For reference | | P_{SAT} | | 28.5 | | dBm | C |
| 2.1 | P1dB output power | | | P1dB | | 27 | | dBm | A |
| 2.2 | Harmonic rejection | $P_{OUT} = 23$ dBm | | 2f _{out} 3f _{out} | | -45 -30 | | dBc dBc | C C |
| 2.3 | Small signal gain | I_{CC_Q} , small signal condition | | GL | | 32 | | dB | A |
| 2.4 | Gain variation | 2.4 to 2.5 GHz, I_{CC_Q} , small signal condition -40 to +85°C, I_{CC_Q} , small signal condition | | $G_{varfreq}$ | | ±1.5 | | dB | C |
| | | | | $G_{vartemp}$ | | ±1.5 | | dB | C |
| 2.5 | Reverse isolation | I_{CC_Q} , small signal condition | | ISO _r | | 40 | | dB | C |
| 2.6 | Input 50Ω VSWR | I_{CC_Q} , small signal condition | | VSWR _{IN} | | 2:1 | | | C |
| 2.7 | Output 50Ω VSWR | I_{CC_Q} , small signal condition, with external matching | | VSWR _{OUT} | | 2:1 | | | C |

*) Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

7. Electrical Characteristics – 11 Mbps CCK Modulation

Test Conditions measured on Atmel's evaluation board (unless otherwise stated): $V_{CC} = 3.3V$, Frequency = 2.45 GHz, $T_{amb} = 25^{\circ}C$, 11 Mbps CCK modulation with Gaussian transmit filtering of BT = 0.4, conforming to IEEE 802.11b

| No. | Parameters | Test Conditions | Pin | Symbol | Min. | Typ. | Max. | Unit | Type* |
|-----|-----------------------------|-----------------------------------|-----|-----------|------|------|------|------|-------|
| 3.0 | Maximum linear output power | ACPR1 ≥ 33 dBc, ACPR2 ≥ 55 dBc | | P_{LIN} | | 23 | | dBm | C |
| 3.1 | Linear power gain | $P_{OUT} = 23$ dBm | | GL | | 32 | | dB | A |
| 3.2 | Current consumption | $P_{OUT} = 23$ dBm | | I_{CC} | | 220 | | mA | A |

*) Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

8. Electrical Characteristics – 54 Mbps OFDM Modulation

Test Conditions measured on Atmel's evaluation board (unless otherwise stated): $V_{CC} = 3.3V$, Frequency = 2.45 GHz, $T_{amb} = 25^{\circ}C$, 54 Mbps OFDM modulation, conforming to IEEE 802.11g; 0.7% EVM measurement equipment noise floor is included in the EVM measurement result.

| No. | Parameters | Test Conditions | Pin | Symbol | Min. | Typ. | Max. | Unit | Type* |
|-----|------------------------|--------------------|-----|----------|------|------|------|------|-------|
| 4.0 | Error vector magnitude | $P_{OUT} = 19$ dBm | | EVM | | 2.0 | | % | C |
| 4.1 | Linear power gain | $P_{OUT} = 19$ dBm | | GL | | 32 | | dB | A |
| 4.2 | Current consumption | $P_{OUT} = 19$ dBm | | I_{CC} | | 150 | | mA | A |

*) Type means: A = 100% tested, B = 100% correlation tested, C = Characterized on samples, D = Design parameter

Figure 10-2. Application Board Layout

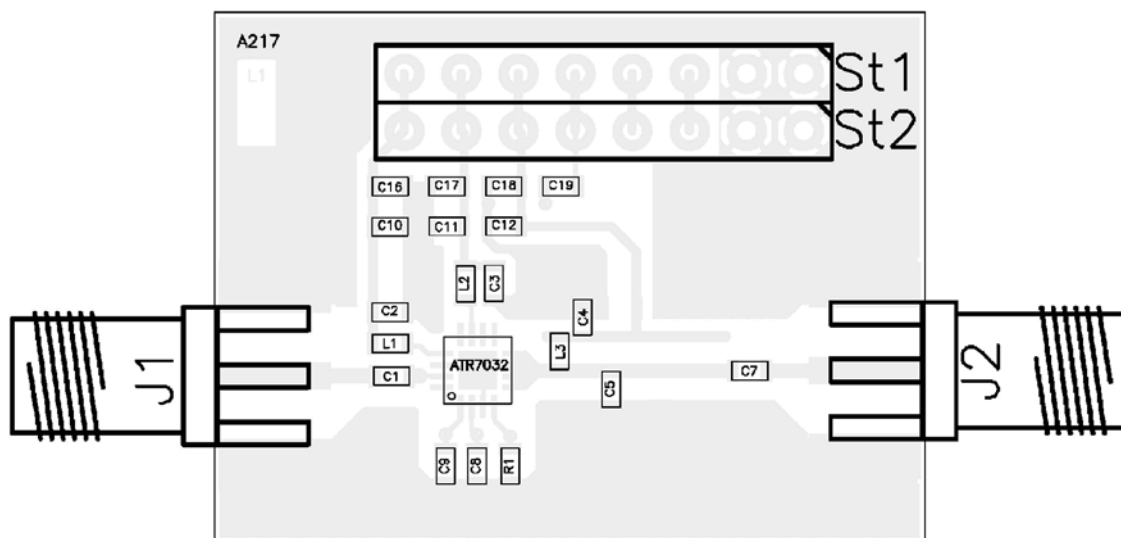


Table 10-1. Bill of Materials for Application Board

| Component | Reference | Value | Size |
|-----------|--------------------------------|-------|------|
| Capacitor | C ₁ | 4p7 | 0603 |
| Capacitor | C ₂ | 56p | 0603 |
| Capacitor | C ₃ | 56p | 0603 |
| Capacitor | C ₄ | 56p | 0603 |
| Capacitor | C ₅ | 1p8 | 0603 |
| Capacitor | C ₇ | 4p7 | 0603 |
| Capacitor | C ₈ | 4p7 | 0603 |
| Capacitor | C ₉ | 4p7 | 0603 |
| Capacitor | C ₁₀ ⁽¹⁾ | 10n | 0603 |
| Capacitor | C ₁₁ ⁽¹⁾ | 10n | 0603 |
| Capacitor | C ₁₂ ⁽¹⁾ | 10n | 0603 |
| Capacitor | C ₁₆ ⁽¹⁾ | 1μ | 0603 |
| Capacitor | C ₁₇ ⁽¹⁾ | 1μ | 0603 |
| Capacitor | C ₁₈ ⁽¹⁾ | 1μ | 0603 |
| Capacitor | C ₁₉ ⁽¹⁾ | 1μ | 0603 |
| Resistor | R ₁ | 22k | 0603 |
| Inductor | L ₁ | 15n | 0603 |
| Inductor | L ₂ | 15n | 0603 |
| Inductor | L ₃ | 15n | 0603 |

Note: 1. Components can be omitted depending on application

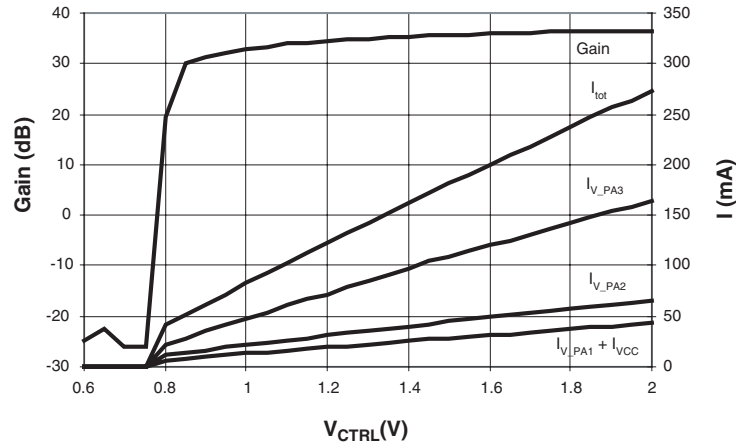
10.1 Evaluation Board Set-up Instructions

After connection of all cables (RF and DC):

- V_{CC} , V_{V_PA1} , V_{V_PA2} , $V_{RF_Out} = 3.3V$
- Increase V_{CTRL} until 90 mA quiescent current without RF signal is reached ($\sim 1.05V$)
- Increase input power until desired linear output power is reached

11. Typical Operating Characteristics

Figure 11-1. Typical Gain and Current versus Control Voltage:



Frequency = 2450 MHz; $P_{In} = -40$ dBm; $V_{V_PA1} = V_{V_PA2} = V_{RF_Out} = V_{CC} = 3.3V$

Figure 11-2. Typical Operating Point for 54 Mbps OFDM Modulation: Frequency = 2450 MHz; $P_{Out} = 19$ dBm; $V_{V_PA1} = V_{V_PA2} = V_{RF_Out} = V_{CC} = 3.3V$

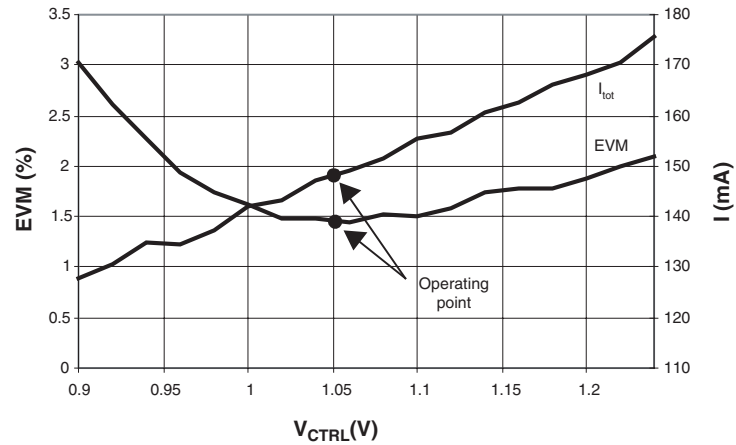


Figure 11-3. Typical S-Parameter at Operating Point: $V_{VCTRL} = 1.05V$; $I_{CC_Q} = 90\text{ mA}$;
 $V_{V_PA1} = V_{V_PA2} = V_{RF_Out} = V_{CC} = 3.3V$

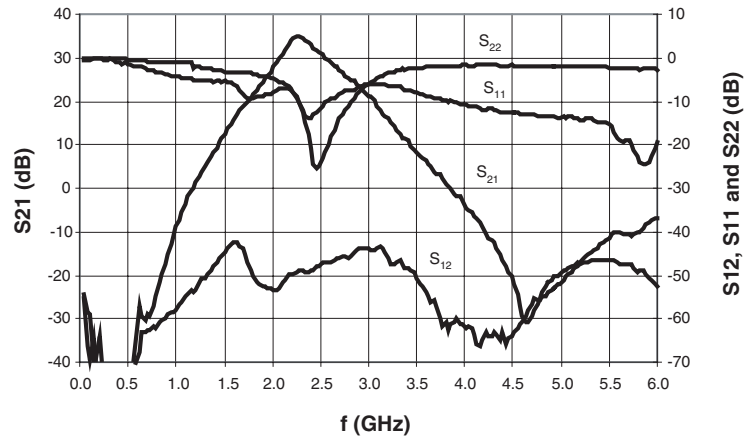


Figure 11-4. Typical S-Parameter at Operating Point (Detail): $V_{VCTRL} = 1.05V$; $I_{CC_Q} = 90\text{ mA}$;
 $V_{V_PA1} = V_{V_PA2} = V_{RF_Out} = V_{CC} = 3.3V$

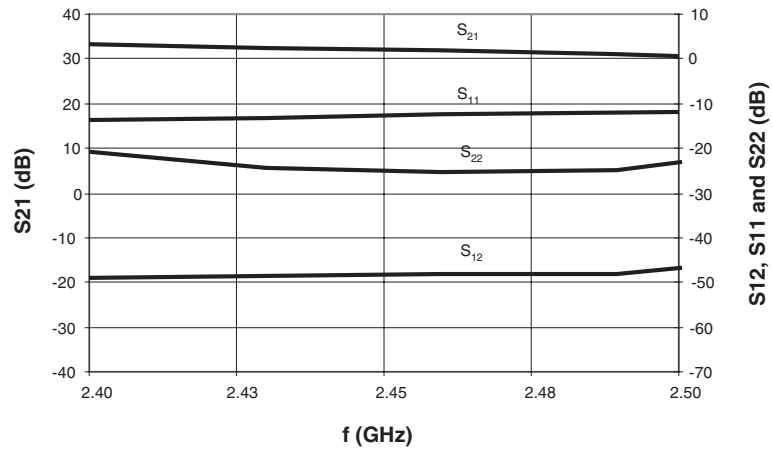


Figure 11-5. Typical Power-sweep with Unmodulated Carrier at Operating Point:
 Frequency = 2450 MHz; $V_{VCTRL} = 1.05V$; $I_{CC_Q} = 90\text{ mA}$;
 $V_{V_PA1} = V_{V_PA2} = V_{RF_Out} = V_{CC} = 3.3V$

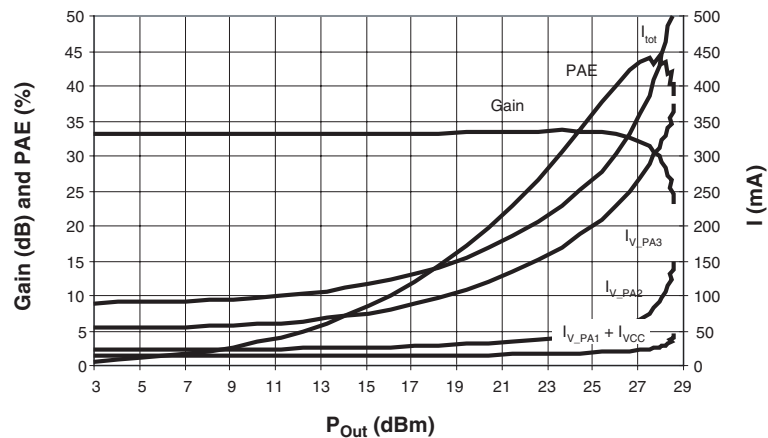


Figure 11-6. Typical Power-sweep with Unmodulated Carrier at Operating Point (Temperature Behavior): Frequency = 2450 MHz; $V_{VCTRL} = 1.05V$; $I_{CC_Q} = 90\text{ mA}$; $V_{V_PA1} = V_{V_PA2} = V_{RF_Out} = V_{CC} = 3.3V$

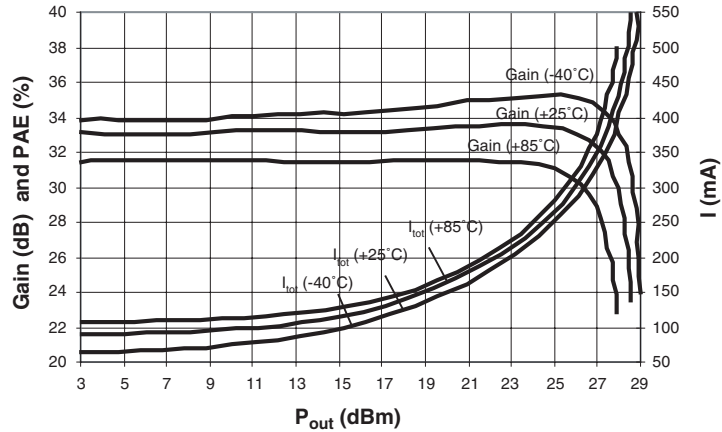


Figure 11-7. Typical Spectral Plot Conforming Compliance to 802.11b Spectral Mask for 11 Mbps CCK Modulation at Operating Point: $P_{Out} = 23\text{ dBm}$; Frequency = 2450 MHz; $V_{VCTRL} = 1.05V$; $I_{CC} = 220\text{ mA}$; $V_{V_PA1} = V_{V_PA2} = V_{RF_Out} = V_{CC} = 3.3V$

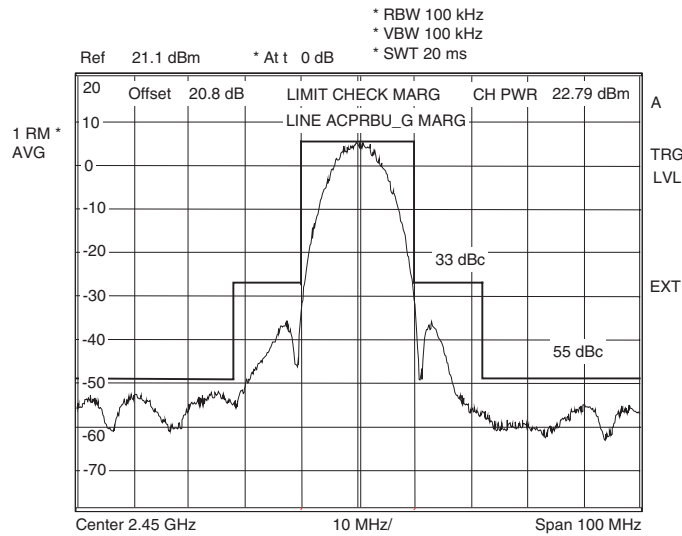


Figure 11-8. Typical Power-sweep with 54 Mbps OFDM Modulation at Operating Point:
 Frequency = 2450 MHz; $V_{VCTRL} = 1.05V$; $I_{CC_Q} = 90\text{ mA}$;
 $V_{V_PA1} = V_{V_PA2} = V_{RF_Out} = V_{CC} = 3.3V$

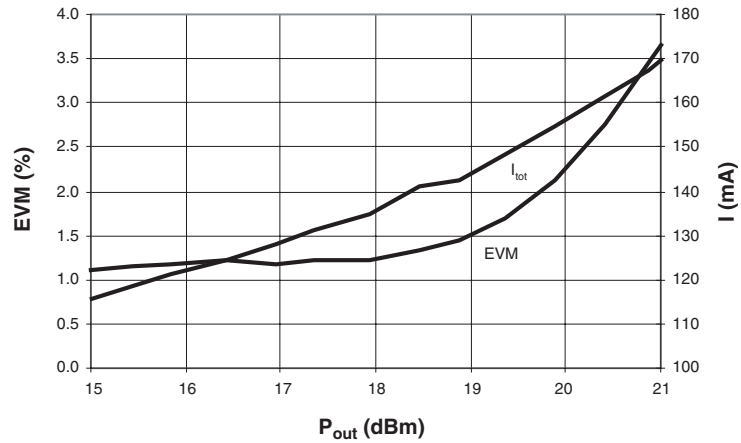


Figure 11-9. Typical Spectral Plot Conforming Compliance to 802.11g Spectral Mask for 54 Mbps OFDM Modulation at Operating Point:
 $P_{Out} = 19\text{ dBm}$; Frequency = 2450 MHz; $V_{VCTRL} = 1.05V$; $I_{CC} = 150\text{ mA}$;
 $V_{V_PA1} = V_{V_PA2} = V_{RF_Out} = V_{CC} = 3.3V$

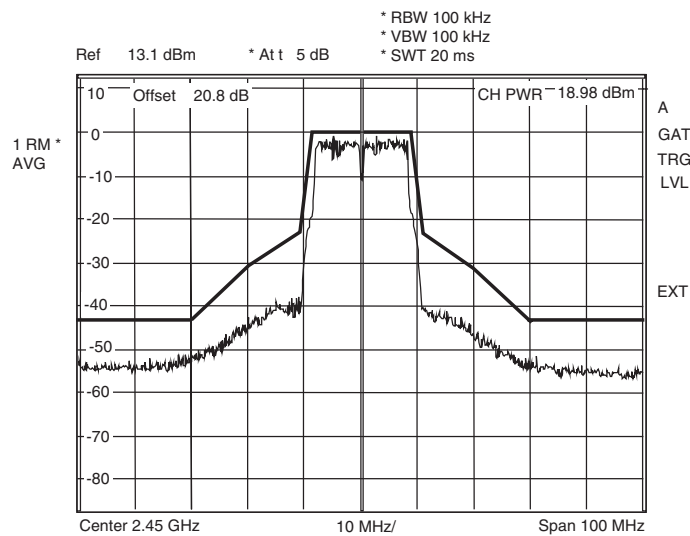


Figure 11-10. Typical Detector Voltage versus P_{Out} for Unmodulated Carrier (Temperature and VCC parameterized): Frequency = 2450 MHz; $V_{VCTRL} = 1.05V$; $I_{CC_Q} = 90\text{ mA}$; $V_{V_{PA1}} = V_{V_{PA2}} = V_{RF_Out} = V_{CC} = 2.7V, 3.3V, 3.6V$; $T_{amb} = -40^{\circ}C, 25^{\circ}C, 85^{\circ}C$

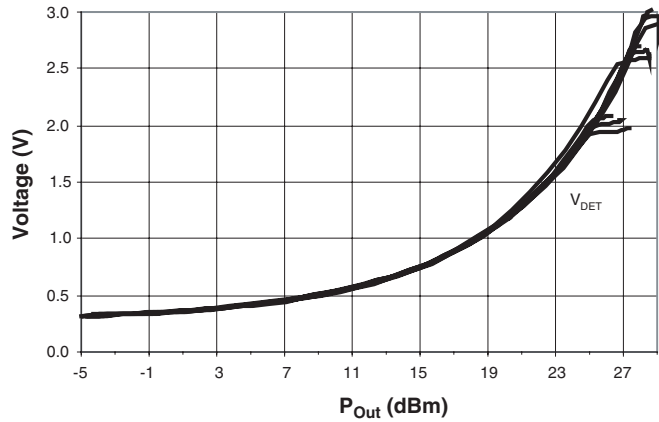


Figure 11-11. Power Detector Response (Rising Edge):

$P_{Out} = 23\text{ dBm}$; Frequency = 2450 MHz; $V_{VCTRL} = 1.05V$; $I_{CC_Q} = 90\text{ mA}$; $V_{V_{PA1}} = V_{V_{PA2}} = V_{RF_Out} = V_{CC} = 3.3V$

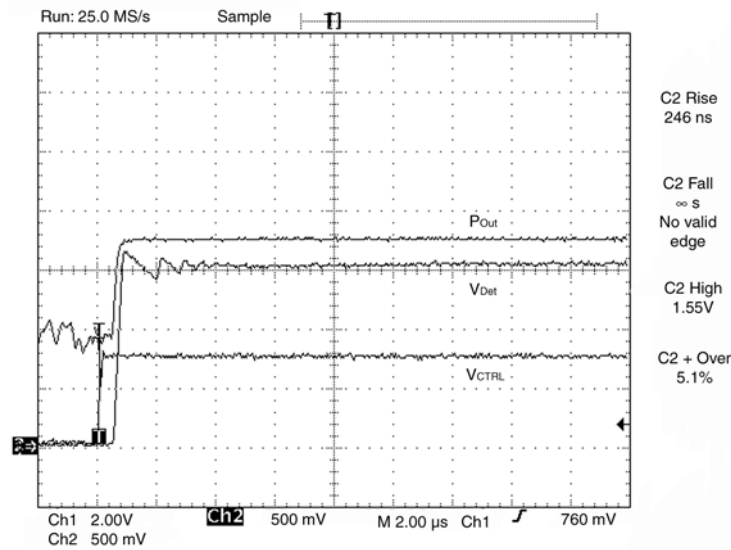
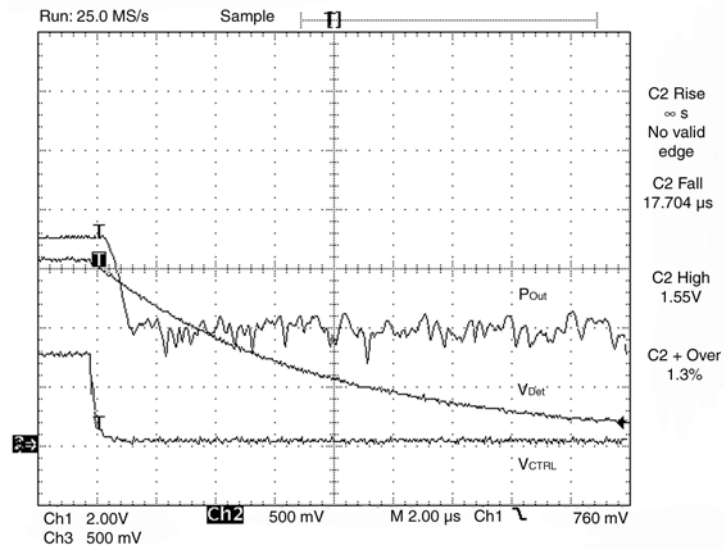


Figure 11-12. Power Detector Response (Falling Edge):

$P_{Out} = 23 \text{ dBm}$; Frequency = 2450 MHz; $V_{VCTRL} = 1.05\text{V}$; $I_{CC_Q} = 90 \text{ mA}$;
 $V_{V_PA1} = V_{V_PA2} = V_{RF_Out} = V_{CC} = 3.3\text{V}$



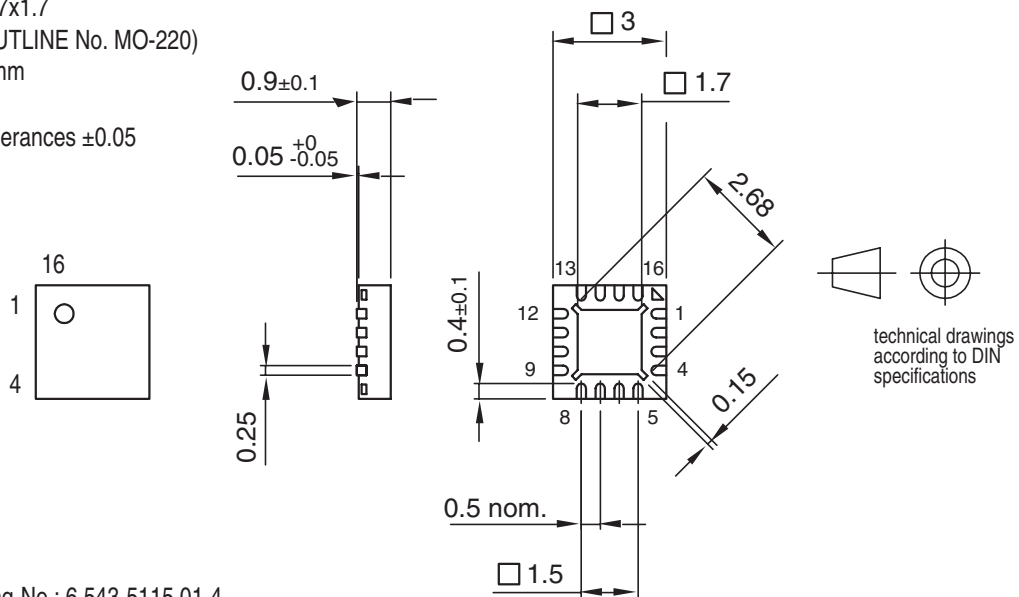
12. Ordering Information

| Extended Type Number | Package | Remarks | MOQ |
|----------------------|--------------|--|-----------|
| ATR7032-PVPW | QFN16, 3 × 3 | Taped and 80 mm reeled, RoHs compliant | 2000 pcs. |
| ATR7032-PVQW | QFN16, 3 × 3 | Taped and 330 mm reeled, RoHs compliant | 8000 pcs. |
| ATR7032-DEV-BOARD | – | Evaluation board | 1 |

13. Package Information

Package: QFN 16 - 3x3
Exposed pad 1.7x1.7
(acc. JEDEC OUTLINE No. MO-220)
Dimensions in mm

Not indicated tolerances ± 0.05



Drawing-No.: 6.543-5115.01-4

Issue: 1; 07.03.05

Assembly Chip PAC

14. Revision History

Please note that the following page numbers referred to in this section refer to the specific revision mentioned, not to this document.

| Revision No. | History |
|------------------|---|
| 4846D-WLAN-10/07 | <ul style="list-style-type: none"> Put datasheet in a new template Section 12 "Ordering Information" on page 14 changed |



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